CRETICAL ITEMS LIST

:- 1

ASSY. NOMENCLATURE __CCTV/ITVC_

ASSY. P/N 20007442G1

[A]LURE EFFECT								
NAME, QTY & DRAWINGS REF. DESIGNATION	LUMCT3ON.	FATEURE NODE AND CAUSE	FNO TEM	INTERFACE	l	CREW/	RATIONALE FOR ACCEPTANCE	DATE
[1VC, 1, Cargo Bay 20007442G1 [TVC 1.8.]	2/2	Thermostat does not close or an open strip heater Thermostat Strip Heater	Degrad— ation of camera vided until self— heating of circuitry restores abrea— tion. Worst Case: Optical elements below minimum tempera— ture. Loss of Mission Critical Viden	No Video	Loss of Missian Critical Video	None	See Sheet 2	
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WP/27290

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DESIGN FEATURES

The ITVC is comprised of 2D electrical subassemblies: 13 subassemblies are Lockhood Martin Astro Space designed and fahricated using standard printed circuit board type construction. The remaining six assem blies. I stepper motors, High Voltage Fuser Supply (MVPS), Intensified CCD (ICCO), and Lens assembly are vendor supplied compoments, which have been specified and purchased according to Lockheed Martin Specification Control Oraminus (SCDs) prepared by Engineering and Product Assurance. Specilications per the SCO are performance, lest, qualification, and acceptance requirements for a procured piece of equipment. Parts. materials, processes, and design guidelines for the ITVC program are specified in accordance with Luckheed Martin 3267028. This document defines the program requirements.

MIL-STO-975G will serve as the primary EEE parts selection document. If a suitable part cannot be found in HIL-STO-975G, equivalent EEE parts that meet the following criteria may be substituted.

Microcircuits are at least Class Blevel, MIL-M-38510 devices. All microcircuits are subjected to Particle Impact Moise Detection (PINO) testing per HTI-SIO-883C (except for devices with plastic enoxytype package).

Olodes and transistors are at least JANIXV in accordance with Htt-S-19500. All semiconductors in cavity-type packages are subjected to PIND testing per M11-510-083C.

DESIGN FEATURES (Cont.)

Relays are procured to the highest military established reliability (MIL-ER) Level as defined in MIL-R-39016. Relays are subject to PIND testing.

Switches are procured to at least the second highest level of the appropriate MII-ER specification. Switches are subjected to either PIND testing or X-ray analysis as appropriate, for particle detection.

Other discrete parts are produced to at least the second highest level of the appropriate MIL-ER specification.

Parts not included in the above documents have been used in the design only after a non-standard parts acceptance request (NSPAR) has been prepared, submitted to Reliability Assurance Engineering and approved for use in the specific application(s) defined in the NSPAR by NASA-JSC.

Norst case circuit analyses have been performed and documented for all circuit designs to demonstrate that sufficient operating margins exist for all operating conditions. The analysis was worst case in that the value for each of the variable parameters was set to limits that will drive the output to a maximum for min.) A component approach review and analysis was conducted to verily that the applied stress on each piece part by the temperature extremes identified with environmental qualification testing does not exceed the stress derating values identified in lockheed Martin 3767870.

DESIGN FEATURES (Cont.)

In addition, an objective examination of the design was performed through a Preliminary Design Review and Eritical Design Review to verify that the ITVC met specification and contractual requirements.

DAME BOARD DESIGN

[All boards are constructed from laminated copper-clad openy glass sheets per Mil-P-13949 Type GF Grade A. Circuit connections are made through printed traces which run from point to point an the buard surfaces. Every trace terminates at an annular ring. The annular ring surrounds the hule in which a component lead or Lerminal is located. This ring provides a footing for the solder, ensuring good mechanical and electrical performance. Its size and shape are governed by MIL-P-\$5640 as are trace widths, spacing and routing, These requirements are reiterated specifically in drawing notes to further assure compliance. Variations between the artwork master and the final product (due to irregularities of the etching process) are also controlled by drawing notes. This prevents making defective boards from good artwork. Holes which house no lead or terminal, but serve only to electrically interconnect the different board layers. contain stitch hars for mechanical support and increased reliability.

The through bules are drilled from a drill tape thus eliminating the possibility of foundation and allowing tight control over hole and annular ring concentricity, an important reliability criterion. After drilling and etching, all copper cladding

BARE UDARD DESIGN (Cont.)
is tim-lead plated per HIL-STD-1495. This
provides for easy and reliable soldering
at the time of board assembly, even after
periods of prolonged storage.

BOARD ASSEMBLY DESIGN

All components are installed in a manner which assures maximum reliability. Component leads are pre-linned, allowing total wetting of solder joints. All leads are furmed to provide stress relief and the hodies of large components are staked. Special mounting and handling instructions are included in each drawing required after final assembly. The board is coated with wrethane which profects against humidity and contamination.

ACCEPTANCE TEST

Each assembly is individually tested in a NASA approved Acceptance Test Procedure IP-AI-20007442. The Acceptance Test Flow is detailed in attacked Table 1.

OUALRFICATION FEST

The Qualification unit is Identical to the flight unit configuration in every respect and is used solely for the purpose of qualification testing. The Qual unit must successfully complete acceptance testing prior to entering qualification testing. The Qual unit has passed testing in accordance with NASA approved test plan PN-C-20007442. The Qualification Test flow is detailed in attached faile 2.

UPERATIONAL TESTS

In order to verify that CCIV components are operational, a test must verify the beatth of all the command related components from the PHS (A7A1) panel switch, through the RCU, through the sync lines to the Camera/PIU, to the Camera/PIU command decoder. The test must also verify the camera's ability to produce video, the VSU's ability to route video, and the montion's ability to display video. A similar test would be performed to verify the MDM command path.

<u>Pre-Launch on Orbiter Test/In-flight Test</u>

- Power CCIV System.
- Via the PNS panel, select a monitor as destination and the camera under test as source.
- Send "Capera Power On" command from the PHS page!
- 4. Select "External Sync" on monitor.
- Observe video displayed on monitor.
 Mote that if video on monitor is synchronized (i.e., stable raster) then this indicates that the camera is receiving composite sync from the RCU and that the camera is producing synchronized video.
- Send Pan, Filt, Focus, Zoom, ALC, and Gomma commands and visually (mither via the monitor or direct observation) verify operation.
- Select downlink as destination and tamera under test as source.
 Observe wideo routed to downlink.
- 9. Send "Camera Power Off" command via
- PIIS panel.
- Repeat Steps 3 through 4 except issue commands via the MDM command path.

QA/INSPECTION

<u>Procurement Control</u> - The 19VC tet Parts and hardware items are procured from approved vendors and suppliers, which must the requirements set forth in the ITVC contract. Resident OPRO personnel review all procurement documents to establish the need for GSI on selected parts (PAI 51V).

<u> Incoming Inspection and Storage - Incoming</u> Quality inspections are made on all received materials and parts. Results are recorded by lot and retained in file by drawing and control numbers for future reference and traceability. All ELE parts are subjected to incoming acceptance tests as called for in PAP A4.14 - Incoming Inspecllion Test Instructions. Incoming flight parts are further processed in accordance [with Lockheed Martin 3267828. Mechanical items are inspected per PAP A4.14 - Supplier Quality Assurance, and PAP EID.B.1 - Procedure for Processing Incoming or Purchased Parts Designated for Flight Use. Accepted items are delivered to Haterial Controlled Stores and retained under specified conditions until fabrication is required. Non-conforming materials are held for Natorial Review Board (MRB) disposition. (PAP A4.14.1

Board Assembly & Test - Prior to the start of TVC board assembly, all items are verified to be correct by stack room personnel, as the items are accumulated to form a kit. The items are verified again by the operator who assembles the kit by checking against the as-built-parts-list (ABPC). UPRO Mandatory Inspection Points are designed for all

QAZINSPLCTION (Cont.)

printed circuit, plus harness connectors for soldering wiring, crimping, solder splices and quality workmanship prior to coating of the component side of boards and sleeving of harnesses.

QA/INSPECTION (Cont.)

LIVC Boards

Specific ITVC board assembly and test instructions are provided in drawing notes. and applicable documents are called out in the Fabrication Procedure and Record (FPR-20007442) and parts list PL20007442. These include Process Standard-Bonding RTV-566 2280881, Process Standard - Bonding Veloro Tape 2280889, Specification Soldering 2280749, Specification - Crimping 2200000, Specification - Monding and Staking 2200070, Specification - Urethane coating 2200877, Specification - Marking 22808/6, Specification - Workmanship 8030035. Specification Bonding and Staking 2280875. Specification-Maye Solder 2280821. Specification-Printed Hire Board Staking 2200051, Specification-Rellow Soldering 2200754, Specification-Soldering Surface Mount Components 20005710.

QAZINSPECTION (Cant.)

TIVE Assembly and Test

An open how test is performed per TP-II-20007442 and an Acceptance Test per TP-AT-20007442, including vibration and thermal vacuum. Torques are specified and witnessed, traceability numbers are recorded and calibrated tools are checked prior to use. Lockheed Hartin Quality and DPRO inspections are performed at the completion of specified FPR operations in accordance with PAP-2.6.1, PAP-2.9, PAP-2.11, PAP-E6.1, and PAP-B.5. IPRO personnel witness 1190 button-up and critical torquing.

The LTVC is packaged according to NASA documents NUMBOOO.IC and NUMBOOO.4(102) which defines packaging and handling requirements. All related documentation including assembly drawings, Parts List, ABPL, Test Data, etc., is gathered and held in a documentation folder assigned specifically to each assembly. This folder is retained for reference. An EIBP is prepared for each assembly in accordance with the requirements of PAP E2.3, tockheed Martin QC and OPHO personnel witness crating, packaging, packing, and marking, and review the EIOP for completeness and accuracy.

TABLE 1. ACCEPTANCE TEST FLOW

1. ROOM AND LENT PERFORMANCE TEST

Test conducted per the requirements of MASA approved TP-AT-20007442.

2. ACCEPTANCE VIBRATION EXPOSURE

20-80 Hz: 3 d0/octave rise from 0.01 g²/Hz to 0.01 g²/Hz to 0.04 g²/Hz 80-350 Hz: 0.04 g²/Hz 350-2000 Hz: 3 dB/octave decrease to 0.006 g²/Hz feet Duration: 1 minute/axis, operating Jest Level: 6.1 gms

POST_VIGRATION FUNCTIONAL CHECK

lest conducted per the requirements of MASA approved IP-AT-20007442.

4. ACCEPTANCE THERMAL-YACUUM EXPOSURE

1.5 cycles total from +115 deg F to +14 deg F. After stabilization, one hour minimum duration at each plateau. Ja-spec functional tests performed at each plateau.

5. POST-ENVIRONMENTAL PERFORMANCE TEST

Room immbient performance tests conducted in accordance with NASA approved IP-AT-2000/442.

TABLE 2. QUALIFICATION TEST FLOW

1. EMI

Conducted tests run in accordance with the requirements of St-E-00020, including CS01, CS02, CS06, 1701, CE01, and CE03, Radiated tests run in accordance with St-E-00020 including RS02, RS03, and RE02 except that the test current for RS02 was 2 amps in lieu of 20 amps.

QUAL FOR ACCEPTANCE_VIBRATION

20-00 Hz: 3 d8/octave increasing to 0.067 g^2/Hz : 80-350 Hz: 0.067/octave

350-2000 Hz: 3 d0/octave decrease

Test Level: 7.8 grms

Test Duration: 5 minutes/axis operating

3. FLIGHT DUALIFICATION VIBRATION

20-70 Hz: 0 d0/ogtave increasing to 0.4 g^2/Hz

70-500 Dz: 0.4 g²/Hz

500-2000 Hz: 6 dB/octave decrease

Test Level: 18.1 grms

Test Ouration: 48 minutes/axis non-operating

4. JHERMAL-YACUUN

7.5 cycles total from +120 deg F to +9 deg F.
After stabilization, one hour minimum duration at each plateau. In-spec functional tests performed at each plateau.

S. IHERNAL STHULATION .

Worst case hol and cold mission environments simulated in vacuum. During but case, in-spec operation is required for 6 of 14 consecutive hours. During cold case, in-spec operation is required for 14 consecutive hours.

6. <u>((UM10)JY</u>

120 hours exposure to 85% RH including four 24 hour temperature cycles of +60 deg f to +125 deg f, non-operating.